

Notice of References Cited	Application/Control No. 09/736,707	Applicant(s)/Patent Under Reexamination HOWELL ET AL.	
	Examiner Alain L. Bashore	Art Unit 3624	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-2002/0165812 A1	11-2002	Lukose, Rajan Mathew	705/37
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NON-PATENT DOCUMENTS

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